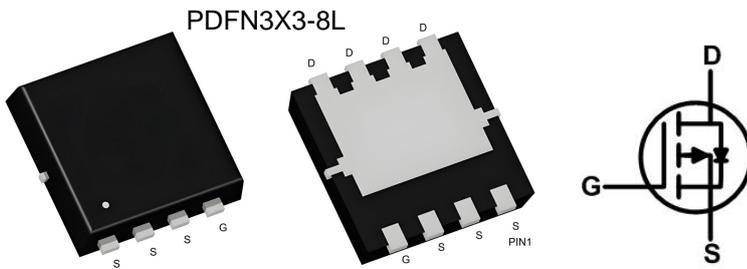


## P-Channel 30V(D-S) MOSFET

| Product summary                        |     |            |
|--|-----|------------|
| $V_{DS}$                               | -30 | V          |
| $R_{DS(ON)}$ (at $V_{GS}=-10V$ ) Typ.  | 11  | m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=-4.5V$ ) Typ. | 17  | m $\Omega$ |
| $I_D$ ( $T_C=25^\circ C$ )             | -20 | A          |

| Features   |
|--|
| <ul style="list-style-type: none"> <li>• Advanced Trench technology</li> <li>• Low Gate Charge</li> </ul>                  |
| Applications   |
| <ul style="list-style-type: none"> <li>• Load switching</li> <li>• PWM Applications</li> <li>• Power Management</li> </ul> |

### Pin Configuration



### Packing Information

| Device     | Package    | Reel Size | Quantity(Min. Package) |
|------------|------------|-----------|------------------------|
| ECAL20P03A | PDFN3X3-8L | 13"       | 3000pcs                |

### Absolute Maximum Ratings (at $T_A=25^\circ C$ Unless Otherwise Noted)

| Symbol         | Parameter                                  | Rating            | Units      |
|----------------|--|-------------------|------------|
| $V_{DS}$       | Drain-Source Voltage                       | -30               | V          |
| $V_{GS}$       | Gate-Source Voltage                        | $\pm 20$          | V          |
| $I_D$          | Continuous Drain Current                   | $T_C=25^\circ C$  | -20 A      |
|                |  | $T_C=100^\circ C$ | -13 A      |
| $I_{DM}$       | Pulse Drain Current Tested <sup>A</sup>    | -60               | A          |
| $E_{AS}$       | Single Pulse Avalanche Energy <sup>B</sup> | 40                | mJ         |
| $P_D$          | Power Dissipation $T_C=25^\circ C$         | 5.4               | W          |
| $T_J, T_{STG}$ | Junction and Storage Temperature Range     | -55 to +150       | $^\circ C$ |

### Thermal Characteristics

| Symbol          | Parameter                               | Typical | Units        |
|-----------------|---|---------|--------------|
| $R_{\theta JC}$ | Thermal Resistance-Junction to case max | 23      | $^\circ C/W$ |

**Electrical Characteristics (at  $T_J = 25^\circ\text{C}$  Unless Otherwise Noted)**

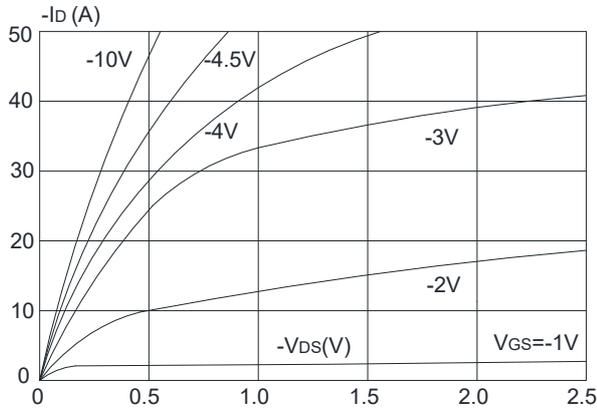
| Symbol                                 | Parameter                                     | Condition  | Min. | Typ. | Max.      | Units      |
|--|---|--|------|------|-----------|------------|
| <b>Static Parameters</b>               |   |  |      |      |           |            |
| $BV_{DSS}$                             | Drain-Source Breakdown Voltage                | $V_{GS}=0V, I_D=-250\mu A$                                       | -30  | --   | --        | V          |
| $I_{DSS}$                              | Zero Gate Voltage Drain Current               | $V_{DS}=-30V, V_{GS}=0V$   | --   | --   | -1        | $\mu A$    |
| $I_{GSS}$                              | Gate-Body Leakage Current                     | $V_{DS}=0V, V_{GS}=\pm 20V$                                      | --   | --   | $\pm 100$ | nA         |
| $V_{GS(th)}$                           | Gate Threshold Voltage                        | $V_{DS}=V_{GS}, I_D=-250\mu A$                                   | -1.0 | -1.6 | -2.5      | V          |
| $R_{DS(ON)}$                           | Drain-Source On-State Resistance <sup>C</sup> | $V_{GS}=-10V, I_D=-10A$  | --   | 11   | 14        | m $\Omega$ |
|  |   | $V_{GS}=-4.5V, I_D=-5A$  | --   | 17   | 24        | m $\Omega$ |
| $V_{SD}$                               | Diode Forward Voltage                         | $I_S=-15A, V_{GS}=0V$  | --   | --   | -1.2      | V          |
| $I_S$                                  | Continuous Source Current                     | $V_G=V_D=0V$ , Force Current                                     | --   | --   | -15       | A          |
| <b>Dynamic Parameters <sup>D</sup></b> |   |  |      |      |           |            |
| $C_{iss}$                              | Input Capacitance                             | $V_{GS}=0V, V_{DS}=-15V$<br>$f=1\text{MHz}$                      | --   | 2070 | --        | pF         |
| $C_{oss}$                              | Output Capacitance                            |  | --   | 273  | --        | pF         |
| $C_{rss}$                              | Reverse Transfer Capacitance                  |  | --   | 246  | --        | pF         |
| $Q_g$                                  | Total Gate Charge                             | $V_{DS}=-15V, I_D=-5A$<br>$V_{GS}=-10V$                          | --   | 22   | --        | nC         |
| $Q_{gs}$                               | Gate-Source Charge                            |  | --   | 4    | --        | nC         |
| $Q_{gd}$                               | Gate-Drain Charge                             |  | --   | 5.8  | --        | nC         |
| $t_{D(on)}$                            | Turn-on Delay Time                            | $V_{DD}=-15V$<br>$I_D=-10A, V_{GS}=-10V,$<br>$R_{GEN}=2.5\Omega$ | --   | 9    | --        | ns         |
| $t_r$                                  | Turn-on Rise Time                             |  | --   | 13   | --        | ns         |
| $t_{D(off)}$                           | Turn-off Delay Time                           |  | --   | 48   | --        | ns         |
| $t_f$                                  | Turn-off Fall Time                            |  | --   | 20   | --        | ns         |
| $t_{rr}$                               | Reverse recovery time                         | $I_F=-2.8A,$<br>$di/dt=100\text{ A/uS}$                          | --   | 64   | --        | ns         |
| $Q_{rr}$                               | Reverse recovery charge                       |  | --   | 25   | --        | nC         |

Note:

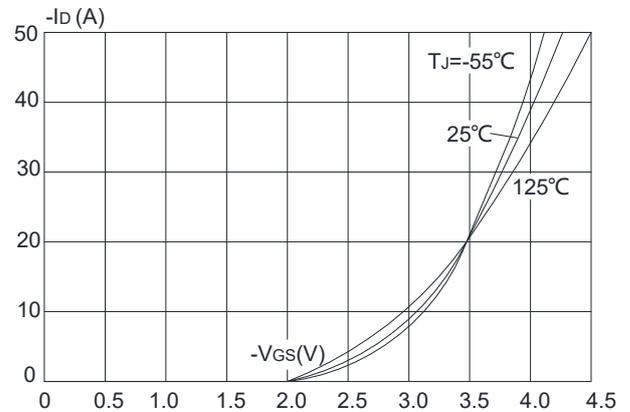
- A. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- B. The EAS data shows Max. rating . The test condition is  $V_{GS}=-10V, L=0.5\text{mH}, I_{AS}=-12.7A, R_g=25\Omega, T_J=25^\circ\text{C}$ .
- C. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$ .
- D. Guaranteed by design, not subject to production testing.

Typical Characteristics

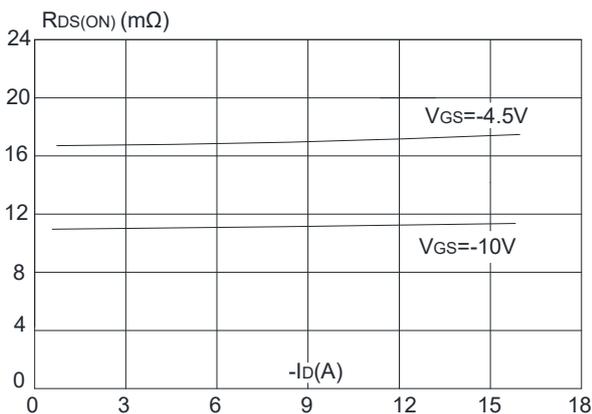
**Figure 1: Output Characteristics**



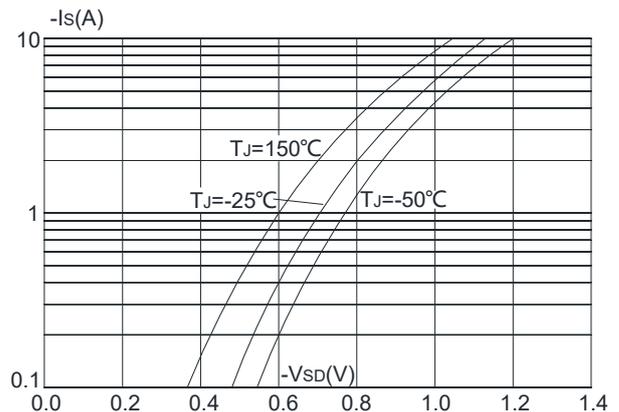
**Figure 2: Typical Transfer Characteristics**



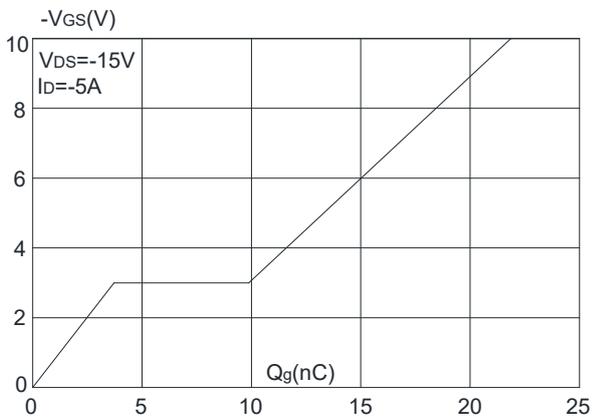
**Figure 3: On-resistance vs. Drain Current**



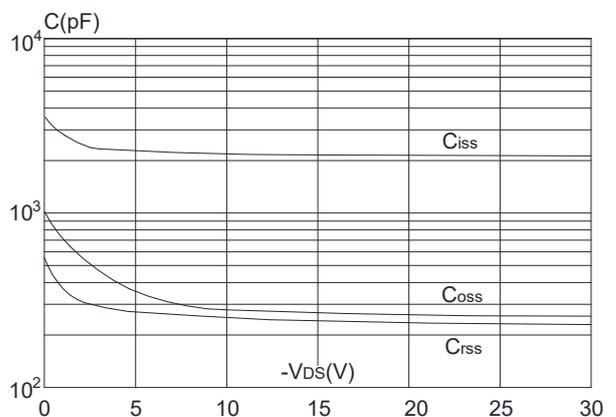
**Figure 4: Body Diode Characteristics**



**Figure 5: Gate Charge Characteristics**

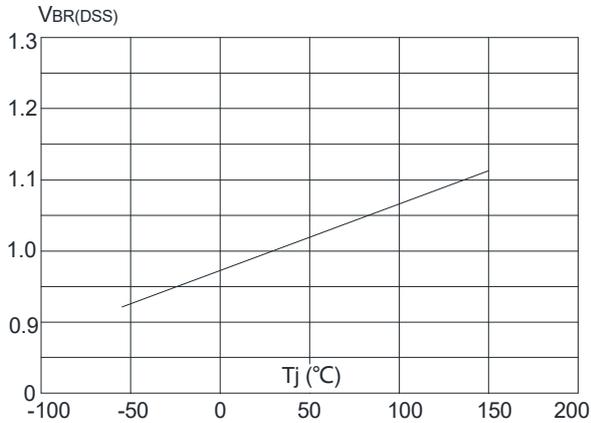


**Figure 6: Capacitance Characteristics**

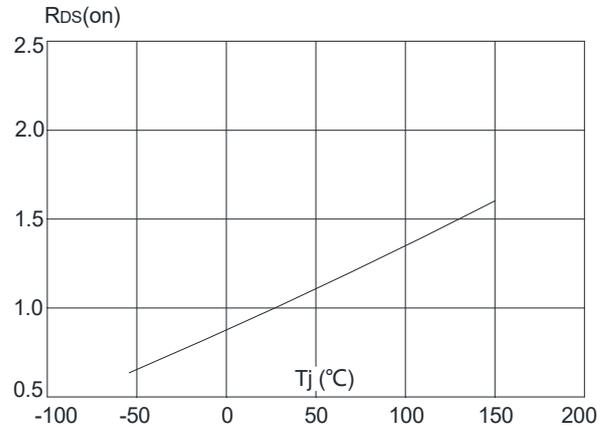


Typical Characteristics

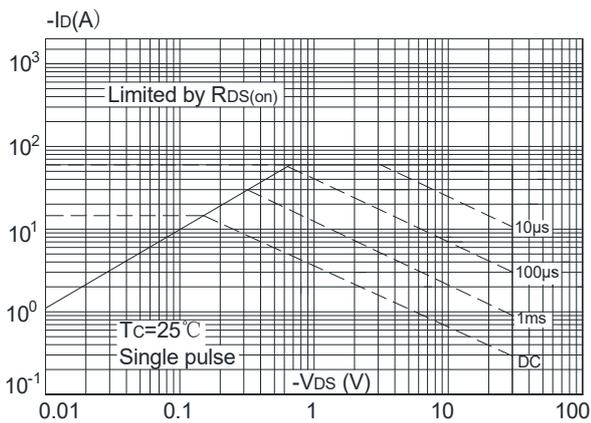
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



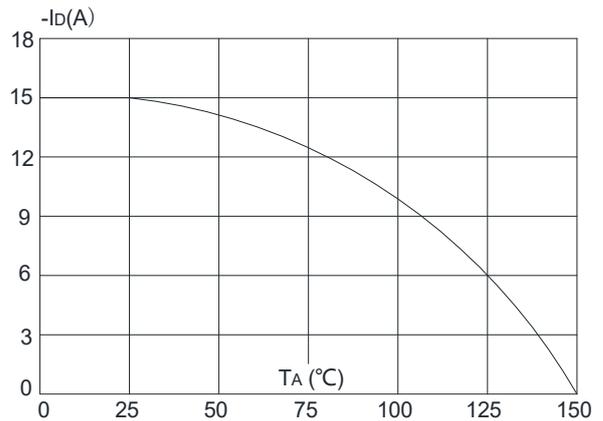
**Figure 8:** Normalized on Resistance vs. Junction Temperature



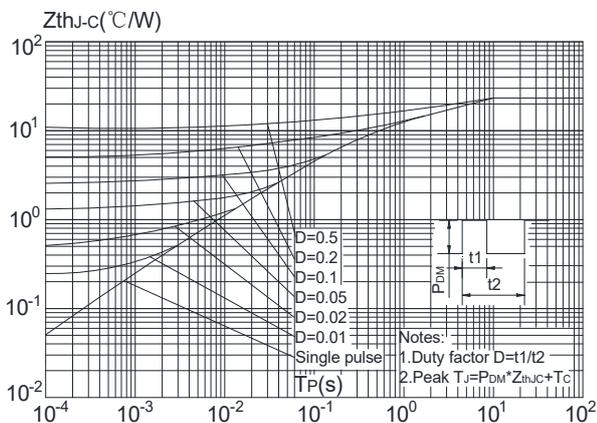
**Figure 9:** Maximum Safe Operating Area



**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature

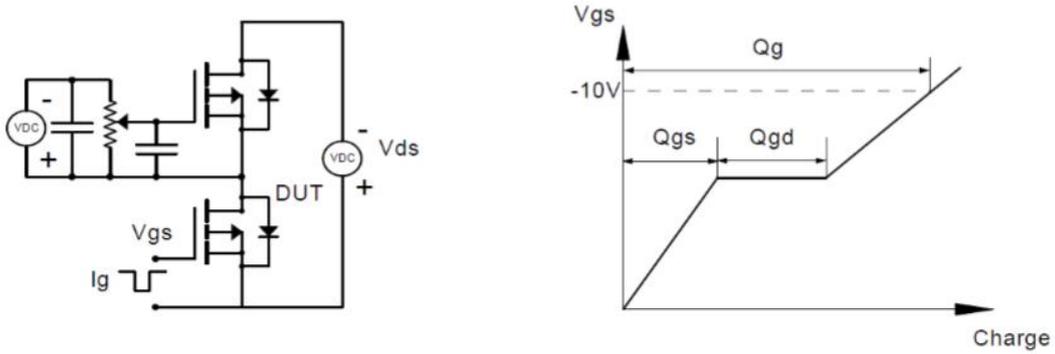


**Figure.11:** Maximum Effective Transient Thermal Impedance, Junction-to-Case

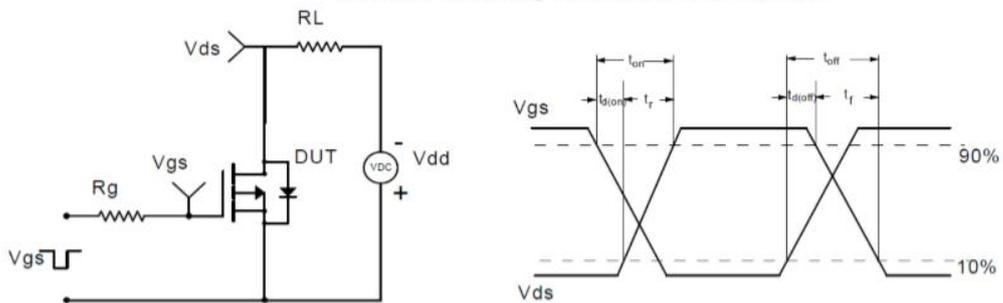


Test Circuit

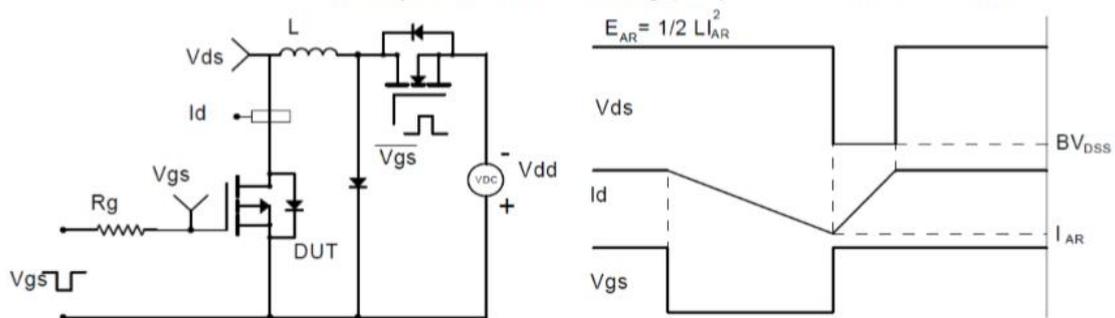
Gate Charge Test Circuit & Waveform



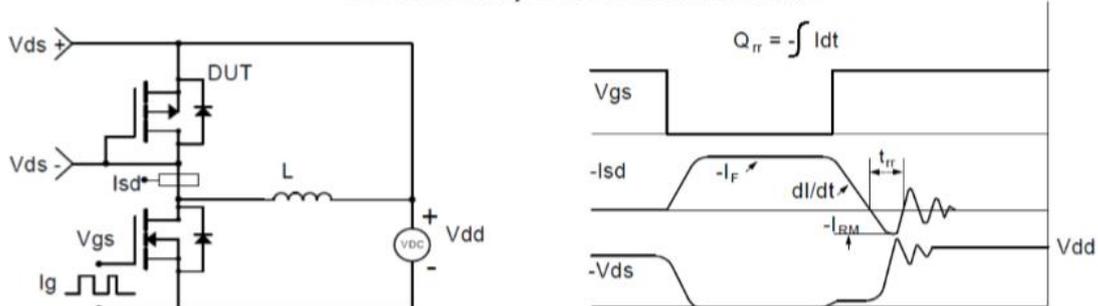
Resistive Switching Test Circuit & Waveforms



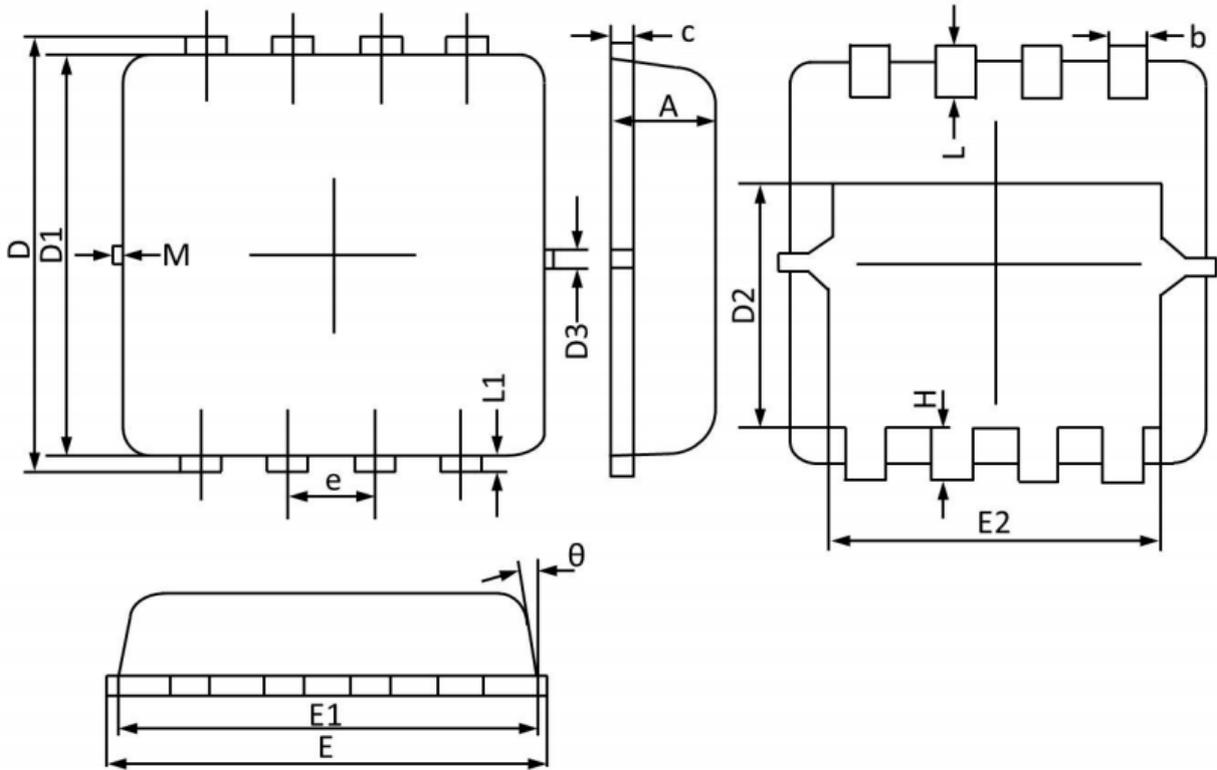
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



## PDFN3X3-8L Package Information (unit:mm)



## DIMENSIONS

| Symbol | Min     | Typ  | Max  | Symbol | Min  | Typ  | Max  |
|--------|---------|------|------|--------|------|------|------|
| A      | 0.70    | 0.75 | 0.80 | b      | 0.25 | 0.30 | 0.35 |
| C      | 0.10    | 0.15 | 0.25 | D      | 3.25 | 3.35 | 3.45 |
| D1     | 3.00    | 3.10 | 3.20 | D2     | 1.78 | 1.88 | 1.98 |
| D3     | --      | 0.13 | --   | E      | 3.20 | 3.30 | 3.40 |
| E1     | 3.00    | 3.15 | 3.20 | E2     | 2.39 | 2.49 | 2.59 |
| e      | 0.65BSC |      |      | H      | 0.30 | 0.39 | 0.50 |
| L      | 0.30    | 0.40 | 0.50 | L1     | --   | 0.13 | --   |
| θ      | --      | 10°  | 12°  | M      | *    | *    | 0.15 |